

N-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY

BV_{DSS}	100V
$R_{DS(on)(MAX.)}$	0.0115 Ω
I_D	70A

FEATURES

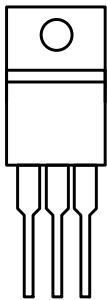
- SGT technology power supply Power MOSFET
- 100 % R_g and UIS Tested



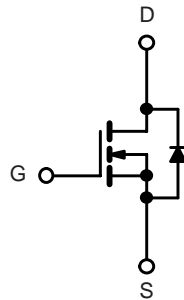
APPLICATIONS

- Battery protection
- Load switch
- Uninterruptible power supply

TO-220AB



G D S
Top View



N-Channel MOSFET

Absolute Maximum Ratings ($T_C = 25\text{ }^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current@10V	I_D	$T_C = 25\text{ }^\circ\text{C}$	70
		$T_C = 100\text{ }^\circ\text{C}$	45
Pulsed Drain Current	I_{DM}	280	A
Single Pulse Avalanche Energy	E_{AS}	110	mJ
Total Power Dissipation	P_D	100	W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 to +150	$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	TYP.	MAX.	Unit
Thermal resistance, junction-to-ambient	$R_{\theta JA}$	-	64	$^\circ\text{C} / \text{W}$
Thermal resistance, junction-to-case	$R_{\theta JC}$	-	1.25	

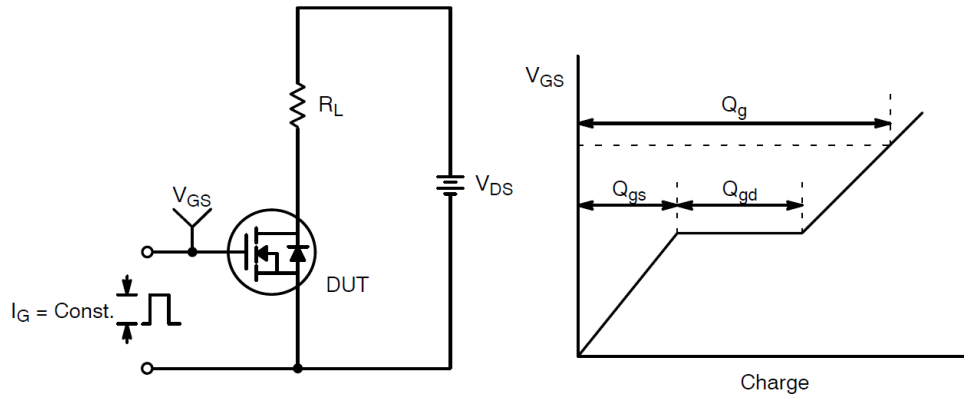
Electrical Characteristics $T_J = 25^\circ\text{C}$, unless otherwise noted

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}$, $I_D = 250\ \mu\text{A}$	100	-	-	V
Gate-body Leakage current	I_{GSS}	$V_{DS} = 0\text{ V}$, $V_{GS} = \pm 20\text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 100\text{ V}$, $V_{GS} = 0\text{ V}$, $T_J = 25^\circ\text{C}$	-	-	1	μA
Gate-Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 250\ \mu\text{A}$	1.2		2.5	V
Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = 10\text{ V}$, $I_D = 20\text{ A}$	-	0.0095	0.0105	Ω
		$V_{GS} = 4.5\text{ V}$, $I_D = 15\text{ A}$	-	0.012	0.016	
Dynamic Characteristics						
Input Capacitance	C_{iss}	$V_{DS} = 50\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$	-	1370	-	pF
Output Capacitance	C_{oss}		-	453	-	
Reverse Transfer Capacitance	C_{rss}		-	13.1	-	
Switching Characteristics						
Gate Resistance	R_g	$f = 1\text{ MHz}$	-	0.48	-	Ω
Total Gate Charge	Q_g	$V_{DS} = 50\text{ V}$, $V_{GS} = 10\text{ V}$, $I_D = 10\text{ A}$	-	31.5	-	nC
Gate-Source Charge	Q_{gs}		-	3.51	-	
Gate-Drain Charge	Q_{gd}		-	7.65	-	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 50\text{ V}$, $I_D \cong 50\text{ A}$, $V_{GEN} = 10\text{ V}$, $R_G = 4\ \Omega$	-	18	-	nS
Rise Time	t_r		-	12	-	
Turn-Off Delay Time	$t_{d(off)}$		-	42	-	
Fall Time	t_f		-	8	-	
Drain-Source Body Diode Characteristics						
Diode Forward Voltage	V_{SD}	$I_S = 10\text{ A}$, $V_{GS} = 0\text{ V}$	-	-	1.2	V
Continuous Source-Drain Diode Current	I_S	$T_J = 25^\circ\text{C}$	-	-	70	A
Reverse Recovery Charge	Q_{rr}	$T_J = 25^\circ\text{C}$, $I_F = 10\text{ A}$, $dI/dt = 100\text{ A}/\mu\text{s}$	-	189	-	nC
Reverse Recovery Time	t_{rr}		-	105	-	ns

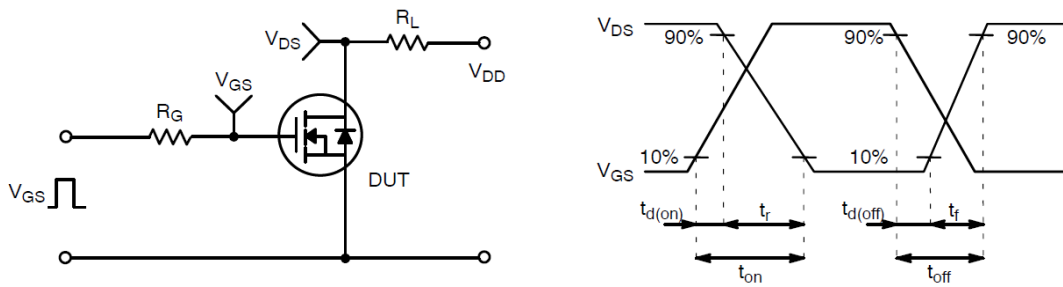
Notes:

- a. Repetitive rating; pulse width limited by maximum junction temperature
b. $V_{DD}=50\text{V}$, $L=0.3\text{mH}$, $R_G=25\Omega$, Starting $T_J=25^\circ\text{C}$

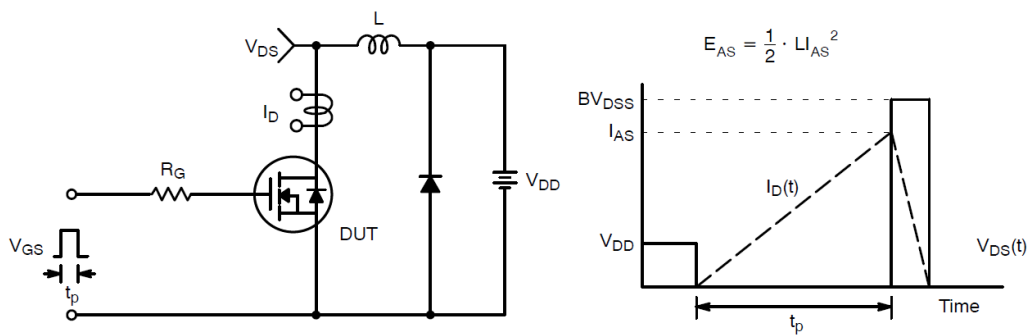
Test circuit and Waveform



Gate Charge Test Circuit & Waveform

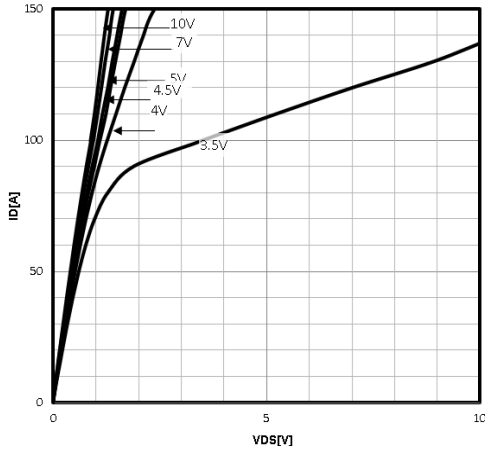


Resistive Switching Test Circuit & Waveforms

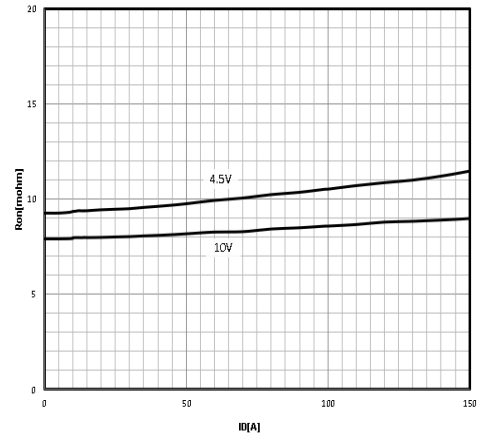


Unclamped Inductive Switching Test Circuit & Waveforms

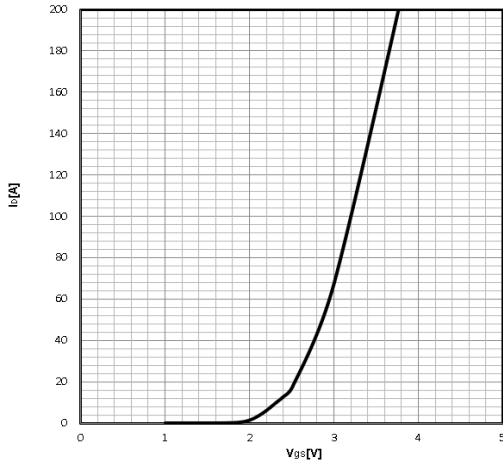
TYPICAL CHARACTERISTICS (25 °C unless noted)



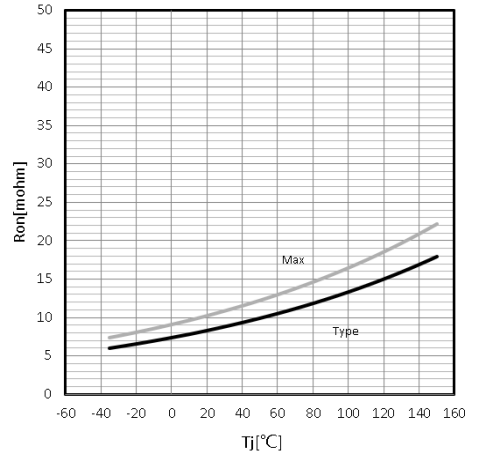
$I_D = f(V_{DS})$
Typ. output characteristics



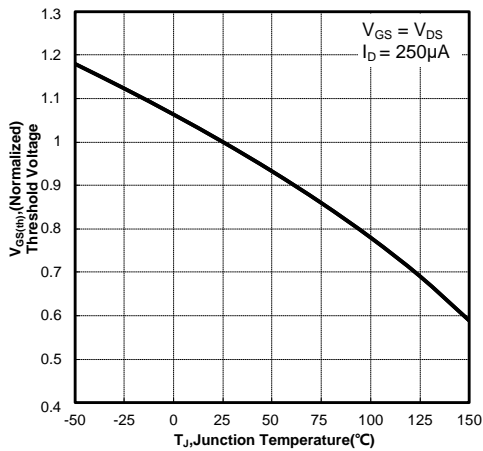
$R_{DS(on)} = f(I_D)$
Typ. drain-source on resistance



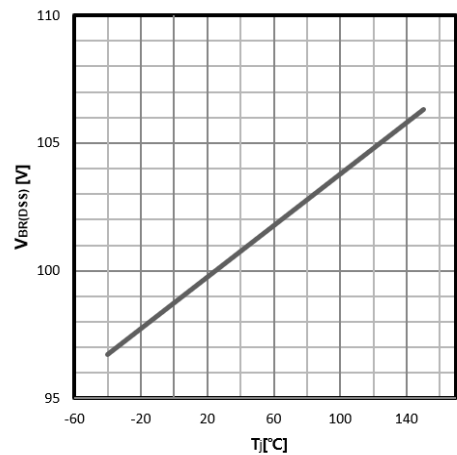
Typ. transfer characteristics



Temperature dependence of $R_{DS(on)}$

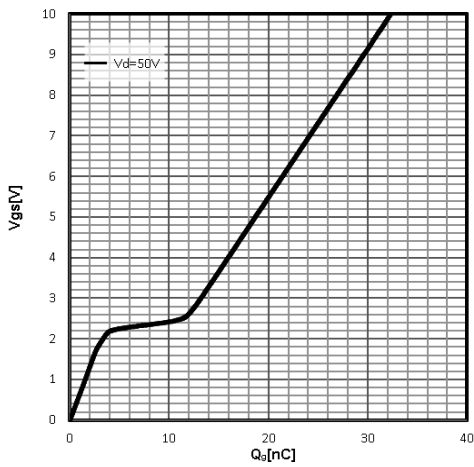


$V_{TH} = f(T_J); I_D = 250\mu A$
Gate Threshold Voltage



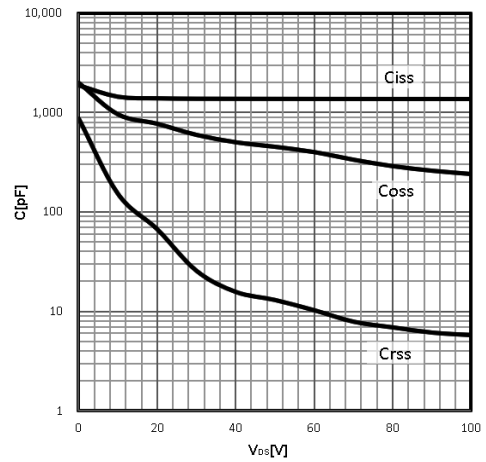
$V_{BR(DSS)} = f(T_J); I_D = 250\mu A$
Drain-source breakdown voltage

TYPICAL CHARACTERISTICS (25 °C unless noted)



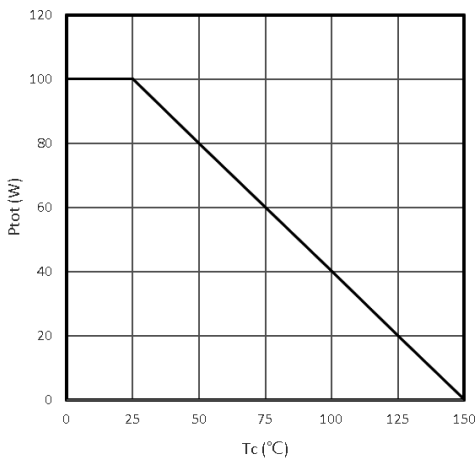
$V_{GS}=f(Q_g)$; $I_D=10A$

Typ. gate charge



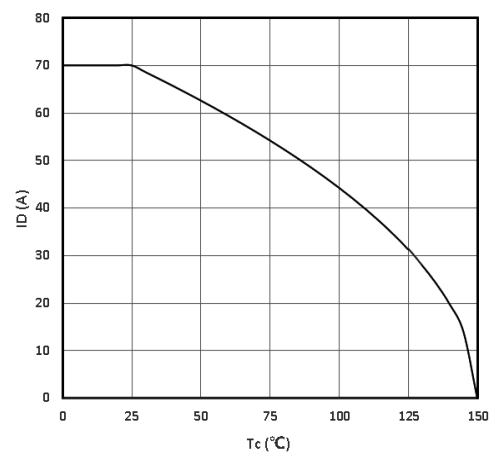
$C=f(V_{DS})$; $V_{GS}=0V$; $f=1MHz$

Typ. capacitances



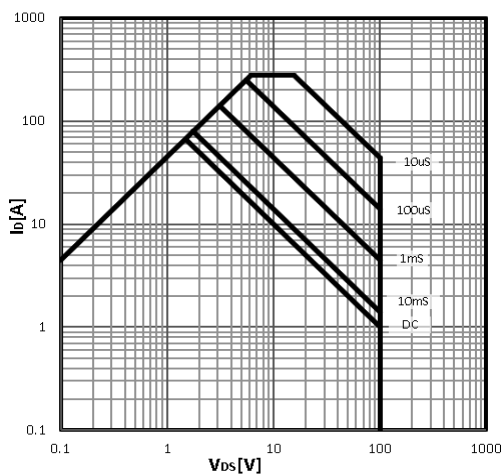
$P_{tot}=f(T_c)$

Power Dissipation



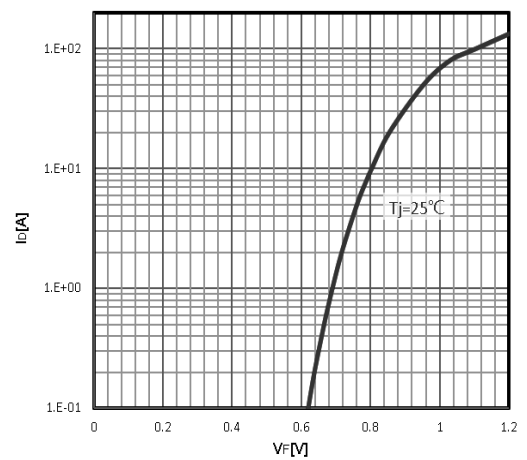
$I_D=f(T_c)$

Maximum Drain Current



$I_D=f(V_{DS})$

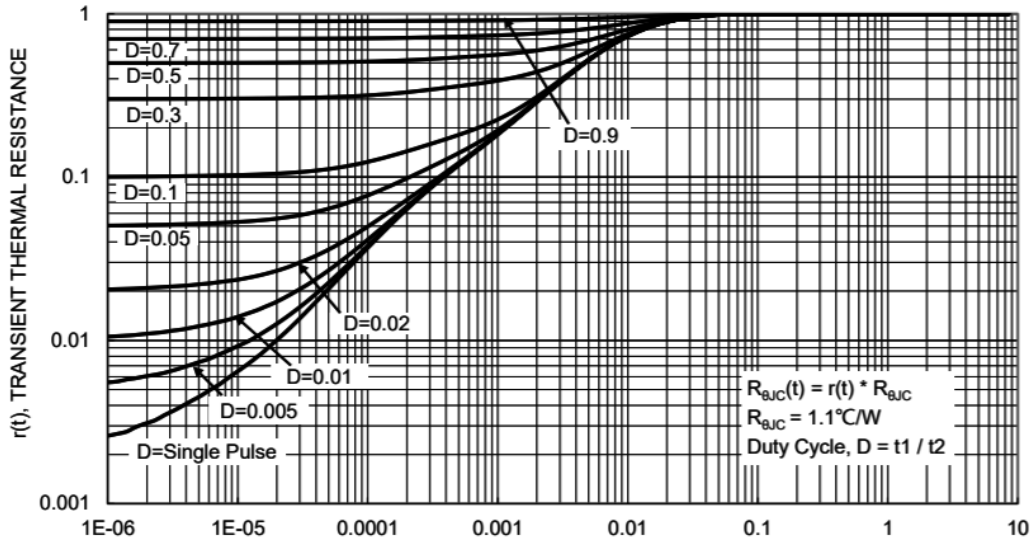
Safe operating area



$I_F=f(V_{GS})$

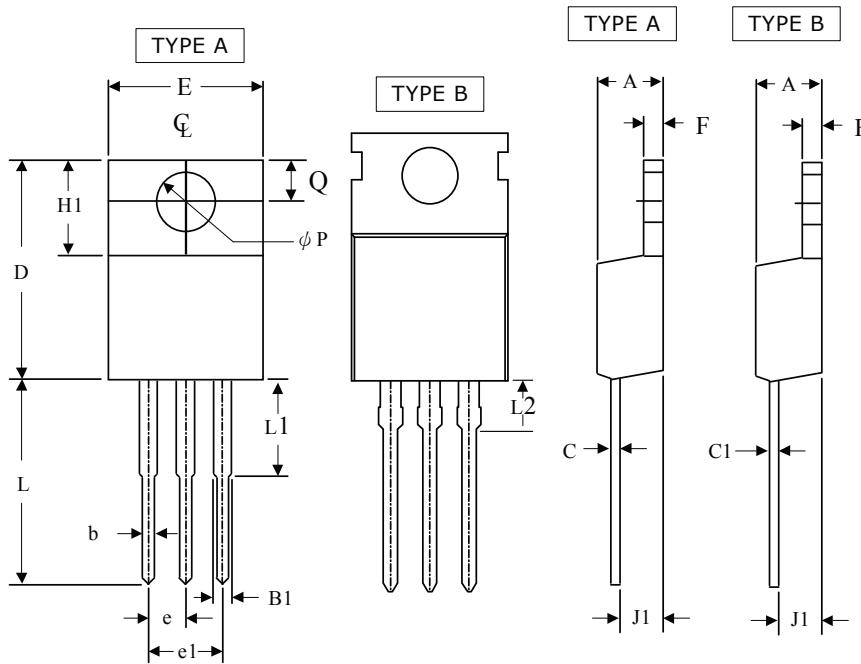
Body Diode Forward Voltage Variation

TYPICAL CHARACTERISTICS (25 °C unless noted)



$Z_{thJC} = f(t_p)$
Max. transient thermal impedance

TO-220 _ PACKGE OUTLIN



SYMBOLS	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.320	4.826	0.170	0.190
B1	1.143	1.778	0.045	0.070
b	0.610	0.910	0.024	0.036
c	0.356	0.530	0.014	0.021
c1	0.45	0.61	0.018	0.024
D	14.224	16.510	0.560	0.650
E	9.652	10.668	0.380	0.420
e	2.540 BSC		0.100 BSC	
e1	5.080 BSC		0.200 BSC	
F	1.220	1.397	0.048	0.055
H1	5.842	6.858	0.230	0.270
J1	2.032	2.921	0.080	0.115
L	12.700	14.732	0.500	0.580
L1	3.400	4.000	0.134	0.150
L2	2.70	3.20	0.106	0.126
ϕP	3.530	4.090	0.139	0.161
Q	2.540	3.429	0.100	0.135